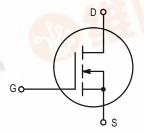
The RF MOSFET Line RF Power Field-Effect Transistor N-Channel Enhancement-Mode

Designed primarily for linear large—signal output stages up to 150 MHz frequency range.

- Specified 28 Volts, 30 MHz Characteristics
 Output Power = 150 Watts
 Power Gain = 15 dB (Typ)
 Efficiency = 40% (Typ)
- Superior High Order IMD
- IMD_(d3) (150 W PEP) -30 dB (Typ)
- IMD(d11) (150 W PEP) -60 dB (Typ)
- 100% Tested For Load Mismatch At All Phase Angles With 30:1 VSWR



MRF140

150 W, to 150 MHz N-CHANNEL MOS LINEAR RF POWER FET



MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Drain-Source Voltage	V _{DSS}	65	Vdc
Drain-Gate Voltage	VDGO	65	Vdc
Gate-Source Voltage	V _{GS}	±40	Vdc
Drain Current — Continuous	ID	16	Adc
Total Device Dissipation @ T _C = 25°C Derate above 25°C	PD	300 1.7	Watts W/°C
Storage Temperature Range	T _{stg}	-65 to +150	°C
Operating Junction Temperature	TJ	200	°C

THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Thermal Resistance, Junction to Case		0.6	°C/W

Handling and Packaging — MOS devices are susceptible to damage from electrostatic charge. Reasonable precautions in handling and packaging MOS devices should be observed.



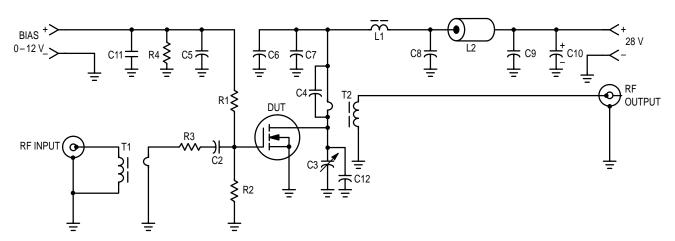


ELECTRICAL CHARACTERISTICS ($T_C = 25^{\circ}C$ unless otherwise noted.)

Characteristic	Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS					
Drain-Source Breakdown Voltage (V _{GS} = 0, I _D = 100 mA)	V(BR)DSS	65	_	_	Vdc
Zero Gate Voltage Drain Current (V _{DS} = 28 Vdc, V _{GS} = 0)	IDSS	_	_	5.0	mAdc
Gate–Body Leakage Current (V _{GS} = 20 Vdc, V _{DS} = 0)	IGSS	_	_	1.0	μAdc
ON CHARACTERISTICS					
Gate Threshold Voltage (V _{DS} = 10 V, I _D = 100 mA)	VGS(th)	1.0	3.0	5.0	Vdc
Drain-Source On-Voltage (VGS = 10 V, ID = 10 Adc)	V _{DS(on)}	0.1	0.9	1.5	Vdc
Forward Transconductance (V _{DS} = 10 V, I _D = 5.0 A)	9fs	4.0	7.0	_	mhos
DYNAMIC CHARACTERISTICS					
Input Capacitance (V _{DS} = 28 V, V _{GS} = 0, f = 1.0 MHz)	C _{iss}	_	450	_	pF
Output Capacitance (V _{DS} = 28 V, V _{GS} = 0, f = 1.0 MHz)	Coss	_	400	_	pF
Reverse Transfer Capacitance ($V_{DS} = 28 \text{ V}, V_{GS} = 0, f = 1.0 \text{ MHz}$)	C _{rss}	_	75	_	pF
FUNCTIONAL TESTS (SSB)					
Common Source Amplifier Power Gain (30 MHz) (V _{DD} = 28 V, P _{out} = 150 W (PEP), I _{DQ} = 250 mA) (150 MHz)	G _{ps}	_ _	15 6.0	_ _	dB
Drain Efficiency (V _{DD} = 28 V, P _{out} = 150 W (PEP), f = 30; 30.001 MHz, I _D (Max) = 6.5 A)	η	_	40	_	%
Intermodulation Distortion (1) $(V_{DD} = 28 \text{ V}, P_{out} = 150 \text{ W} (PEP), f1 = 30 \text{ MHz}, f2 = 30.001 \text{ MHz}, I_{DQ} = 250 \text{ mA})$	IMD _(d3) IMD _(d11)	_ _	-30 -60	_ _	dB
Load Mismatch (V _{DD} = 28 V, P _{out} = 150 W (PEP), f = 30; 30.001 MHz, I _{DQ} = 250 mA, VSWR 30:1 at all Phase Angles)	Ψ	No Degradation in Output Power			

NOTE:

^{1.} To MIL-STD-1311 Version A, Test Method 2204B, Two Tone, Reference Each Tone.



C2, C5, C6, C7, C8, C9 — 0.1 μF Ceramic Chip or Monolythic with Short Leads

C3 — Arco 469 C4 — 820 pF Unencapsulated Mica or Dipped Mica with Short Leads

 $C10 - 10 \, \mu F/100 \, V$ Electrolytic

C11 — 1 μ F, 50 V, Tantalum

C12 — 330 pF, Dipped Mica (Short leads)

L1 — VK200/4B Ferrite Choke or Equivalent, 3.0 μH

L2 — Ferrite Bead(s), 2.0 μH

R1, R2 — 51 Ω /1.0 W Carbon

R3 — 1.0 Ω /1.0 W Carbon or Parallel Two 2 Ω , 1/2 W Resistors

R4 — 1 k Ω /1/2 W Carbon

T1 — 16:1 Broadband Transformer

T2 — 1:25 Broadband Transformer

Figure 1. 30 MHz Test Circuit (Class AB)

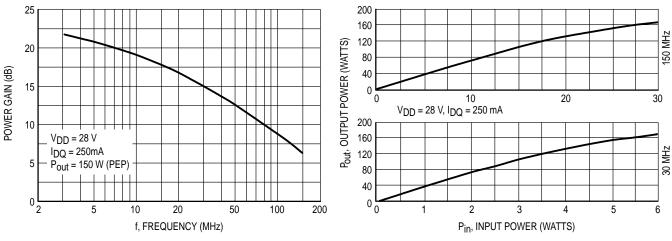


Figure 2. Power Gain versus Frequency

Figure 3. Output Power versus Input Power

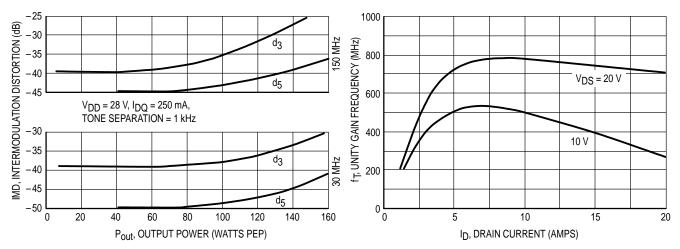


Figure 4. IMD versus Pout

Figure 5. Common Source Unity Gain Frequency versus Drain Current

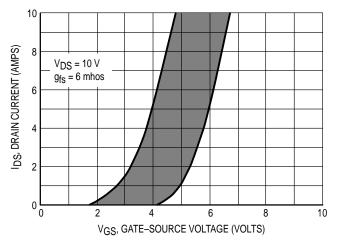


Figure 6. Gate Voltage versus Drain Current

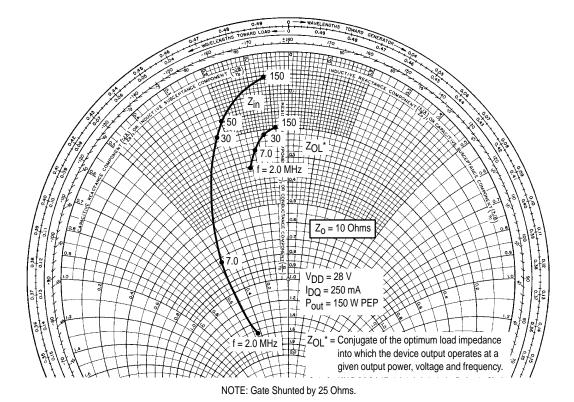


Figure 7. Series Equivalent Impedance

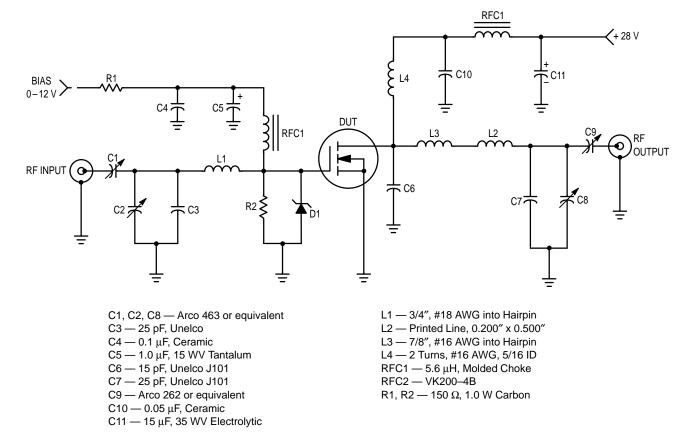


Figure 8. 150 MHz Test Circuit (Class AB)

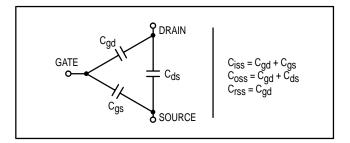
RF POWER MOSFET CONSIDERATIONS

MOSFET CAPACITANCES

The physical structure of a MOSFET results in capacitors between the terminals. The metal oxide gate structure determines the capacitors from gate–to–drain (C_{gd}), and gate–to–source (C_{gs}). The PN junction formed during the fabrication of the RF MOSFET results in a junction capacitance from drain–to–source (C_{ds}).

These capacitances are characterized as input (C_{iss}) , output (C_{oss}) and reverse transfer (C_{rss}) capacitances on data sheets. The relationships between the inter–terminal capacitances and those given on data sheets are shown below. The C_{iss} can be specified in two ways:

- 1. Drain shorted to source and positive voltage at the gate.
- Positive voltage of the drain in respect to source and zero volts at the gate. In the latter case the numbers are lower. However, neither method represents the actual operating conditions in RF applications.



LINEARITY AND GAIN CHARACTERISTICS

In addition to the typical IMD and power gain data presented, Figure 5 may give the designer additional information on the capabilities of this device. The graph represents the small signal unity current gain frequency at a given drain current level. This is equivalent to f_{T} for bipolar transistors.

Since this test is performed at a fast sweep speed, heating of the device does not occur. Thus, in normal use, the higher temperatures may degrade these characteristics to some extent.

DRAIN CHARACTERISTICS

One figure of merit for a FET is its static resistance in the full—on condition. This on–resistance, $V_{DS(on)}$, occurs in the linear region of the output characteristic and is specified under specific test conditions for gate—source voltage and drain current. For MOSFETs, $V_{DS(on)}$ has a positive temperature coefficient and constitutes an important design consideration at high temperatures, because it contributes to the power dissipation within the device.

GATE CHARACTERISTICS

The gate of the RF MOSFET is a polysilicon material, and is electrically isolated from the source by a layer of oxide. The input resistance is very high — on the order of 10⁹ ohms — resulting in a leakage current of a few nanoamperes.

Gate control is achieved by applying a positive voltage slightly in excess of the gate-to-source threshold voltage, VGS(th).

Gate Voltage Rating — Never exceed the gate voltage rating. Exceeding the rated VGS can result in permanent damage to the oxide layer in the gate region.

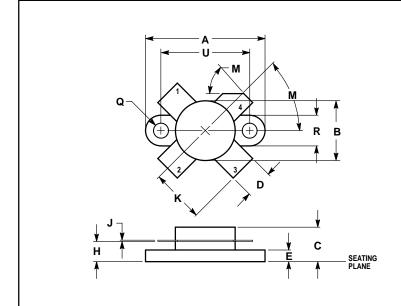
Gate Termination — The gates of these devices are essentially capacitors. Circuits that leave the gate open—circuited or floating should be avoided. These conditions can result in turn—on of the devices due to voltage build—up on the input capacitor due to leakage currents or pickup.

Gate Protection — These devices do not have an internal monolithic zener diode from gate—to—source. If gate protection is required, an external zener diode is recommended.

EQUIVALENT TRANSISTOR PARAMETER TERMINOLOGY

Carrier Carrier	
Emitter Source	
Base Gate	
V(BR)CES·······V(BR)DSS	
V _{CBO} V _{DGO}	
IC ID	
ICES IDSS	
I _{EBO} I _{GSS}	
VBE(on) VGS(th)	
VCE(sat) · · · · · · · · · · · · VDS(on)	
C _{ib} C _{iss}	
C_ob C_oss	
h _{fe} gfs	
$R_{CE(sat)} = \frac{V_{CE(sat)}}{I_{C}}$ $r_{DS(on)} = \frac{V_{DS}}{I_{L}}$	<u>(on)</u>)

PACKAGE DIMENSIONS



- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
- 2. CONTROLLING DIMENSION: INCH.

	INCHES		MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.960	0.990	24.39	25.14
В	0.465	0.510	11.82	12.95
C	0.229	0.275	5.82	6.98
ם	0.216	0.235	5.49	5.96
Е	0.084	0.110	2.14	2.79
Н	0.144	0.178	3.66	4.52
7	0.003	0.007	0.08	0.17
K	0.435		11.05	
М	45°	NOM	45°	NOM
Q	0.115	0.130	2.93	3.30
R	0.246	0.255	6.25	6.47
U	0.720	0.730	18.29	18.54

STYLE 2:

PIN 1. SOURCE 2. GATE

3. SOURCE 4. DRAIN

CASE 211-11 ISSUE N

Motorola reserves the right to make changes without further notice to any products herein. Motorola makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does Motorola assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation consequential or incidental damages. "Typical" parameters which may be provided in Motorola data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. Motorola does not convey any license under its patent rights nor the rights of others. Motorola products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or other applications intended to support or sustain life, or for any other application in which the failure of the Motorola product could create a situation where personal injury $or death\ may\ occur.\ Should\ Buyer\ purchase\ or\ use\ Motorola\ products\ for\ any\ such\ unintended\ or\ unauthorized\ application,\ Buyer\ shall\ indemnify\ and\ hold\ Motorola\ products\ for\ any\ such\ unintended\ or\ unauthorized\ application,\ Buyer\ shall\ indemnify\ and\ hold\ Motorola\ products\ for\ any\ such\ unintended\ or\ unauthorized\ application,\ Buyer\ shall\ indemnify\ and\ hold\ Motorola\ products\ for\ any\ such\ unintended\ or\ unauthorized\ application,\ Buyer\ shall\ indemnify\ and\ hold\ Motorola\ products\ for\ any\ such\ unintended\ or\ unauthorized\ application,\ buyer\ shall\ indemnify\ and\ hold\ Motorola\ products\ for\ any\ such\ unintended\ or\ unauthorized\ application,\ buyer\ shall\ indemnify\ and\ hold\ Motorola\ products\ for\ any\ such\ unintended\ or\ unauthorized\ application,\ buyer\ shall\ indemnify\ and\ hold\ Motorola\ products\ for\ any\ such\ unintended\ products\ for\ any\ such\ any\ such\ any\ such\ any\ such\ any\$ and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that Motorola was negligent regarding the design or manufacture of the part. Motorola and (M) are registered trademarks of Motorola, Inc. Motorola, Inc. is an Equal Opportunity/Affirmative Action Employer.

How to reach us:

USA/EUROPE/Locations Not Listed: Motorola Literature Distribution; P.O. Box 5405, Denver, Colorado 80217. 303-675-2140 or 1-800-441-2447

JAPAN: Nippon Motorola Ltd.: SPD, Strategic Planning Office, 4-32-1, Nishi-Gotanda, Shinagawa-ku, Tokyo 141, Japan. 81-3-5487-8488

Mfax™: RMFAX0@email.sps.mot.com – TOUCHTONE 602–244–6609 - US & Canada ONLY 1-800-774-1848 INTERNET: http://motorola.com/sps

ASIA/PACIFIC: Motorola Semiconductors H.K. Ltd.; 8B Tai Ping Industrial Park, 51 Ting Kok Road, Tai Po, N.T., Hong Kong. 852-26629298

MOTOROLA

Mfax is a trademark of Motorola, Inc.